

# LIST OF ART CITED BY APPLICANT

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 APPLICANT(S)  
**Yoon-Seob EOM et al.**

 FILING DATE  
**April 21, 2006**

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**3744**

## U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	*PATENT NO.	*ISSUE DATE	*INVENTOR NAME	CLASS	SUBCLASS	FILING DATE
	<b>2,941,382</b>	<b>06/1960</b>	<b>Edward M. Wuesthoff</b>			

## U.S. PATENT APPLICATION PUBLICATIONS

	*PATENT APPLN. PUB. NO.	*PUB. DATE	*APPLICANT	CLASS	SUBCLASS	

## U.S. PATENT APPLICATIONS

	*APPLN. NO.	*FILING DATE	*INVENTOR	CLASS	SUBCLASS	

## FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
	<b>JP 08-285321</b>	<b>11/01/1996</b>	<b>Japan (English Abstract and Japanese Full Text)</b>			<b>X</b>	
	<b>JP 06-002888</b>	<b>01/11/1994</b>	<b>Japan (English Abstract and Japanese Full Text)</b>			<b>X</b>	
	<b>DE 16 04 240</b>	<b>09/03/1970</b>	<b>Germany (German Full Text Only)</b>				
	<b>DE 16 04 243</b>	<b>12/10/1970</b>	<b>Germany (German Full Text Only)</b>				

## OTHER ART (Including Author, Title, Date, Pertinent Pages, Publisher, Place of Publication, Etc.)

EXAMINER	DATE CONSIDERED

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

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